## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | Notice of References Cited Examiner | Art Unit | Page 1 of 1 | Notice | Notic

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0118438 A1	06-2005	Katsuki et al.	428/458
	В	US-2004/0076765 A1	04-2004	Katsuki et al.	427/535
	С	US-2003/0198828 A1	10-2003	Huang et al.	428/626
	D	US-2003/0049487 A1	03-2003	Katsuki et al.	428/626
	E	US-2003/0012927 A1	01-2003	Katsuki et al.	428/141
	F	US-6,838,184 B2	01-2005	Takahashi et al.	428/473.5
	G	US-6,440,576 B1	08-2002	Yamamoto et al.	428/473.5
	Н	US-6,251,507 B1	06-2001	Yamamoto et al.	428/215
	ı	US-			
	J	US-			
	К	US-			
	L	US-		·	,
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N <sup>4</sup>	JP 11-031868	02-1999	JP	MIKI ET AL.	
	0 /	JP 06-210794	08-1994	JP	SUGIMOTO ET AL.	
	Ρ/	JP 06-124978	05-1994	JP.	SUGIMOTO ET AL.	
	Q /	EP 0 280502	08-1988	EPA	KNUDSEN ET AL.	
	R					
	s		-0			
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.